

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/738,548	ADACHI, NOKIHISA		
Examiner	Art Unit		
Ren L. Yan	2854		

SEARCHED					
Class	Subclass	Date	Examiner		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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